

## GL Silicon N-Channel Power MOSFET

### General Description :

GL13N65FA9, the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-220F, which accords with the RoHS standard.

### Features :

- Fast Switching
- Low ON Resistance
- Low Gate Charge
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

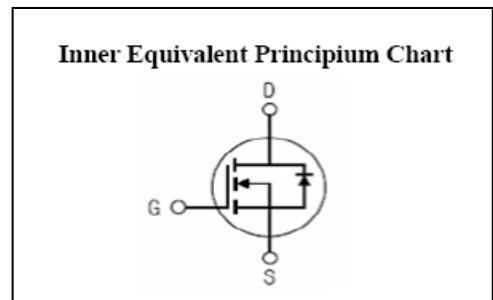
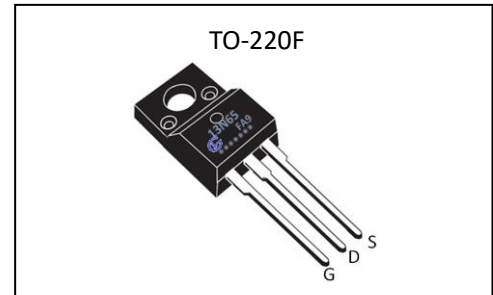
### Applications :

- Power switch circuit of adaptor and charger

### Absolute ( Tc= 25°C unless otherwise specified ) :

Symbol	Parameter	Rating	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	650	V
I <sub>D</sub>	Continuous Drain Current	13	A
	Continuous Drain Current T <sub>c</sub> = 100 °C	8.8	A
I <sub>DM</sub> <sup>a1</sup>	Pulsed Drain Current	52	A
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub> <sup>a2</sup>	Single Pulse Avalanche Energy	1050	mJ
E <sub>AR</sub> <sup>a1</sup>	Avalanche Energy ,Repetitive	100	mJ
I <sub>AR</sub> <sup>a1</sup>	Avalanche Current	4.3	A
dv/dt <sup>a3</sup>	Peak Diode Recovery dv/dt	5.0	V/ns
P <sub>D</sub>	Power Dissipation	50	W
	Derating Factor above 25°C	0.4	W/°C
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	150 , -55 to 150	°C
T <sub>L</sub>	Maximum Temperature for Soldering	300	°C

V <sub>DSS</sub> (T <sub>C</sub> =150°C)	650	V
I <sub>D</sub>	13	A
P <sub>D</sub> (T <sub>C</sub> =25°C)	50	W
R <sub>DS(ON)MAX</sub>	0.55	Ω





## GL Silicon N-Channel Power MOSFET

Electrical Characteristics ( Tc= 25°C unless otherwise specified ) :

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V <sub>DSS</sub>	Drain to Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	650	--	--	V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Bvdss Temperature Coefficient	I <sub>D</sub> =250uA, Reference 25°C	--	0.74	--	V/°C
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V, T <sub>a</sub> =25°C	--	--	1	μA
		V <sub>DS</sub> =520V, V <sub>GS</sub> =0V, T <sub>a</sub> =125°C	--	--	100	
I <sub>GSS(F)</sub>	Gate to Source Forward Leakage	V <sub>GS</sub> = +30V	--	--	10	μA
I <sub>GSS(R)</sub>	Gate to Source Reverse Leakage	V <sub>GS</sub> = -30V	--	--	-10	μA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R <sub>DS(ON)</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =6.5A	--	0.485	0.55	Ω
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2.0	--	4.0	V
Pulse width tp ≤ 300μs, δ ≤ 2%						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =15V, I <sub>D</sub> =6.5A	--	13	--	S
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V V <sub>DS</sub> =25V f=1.0MHz	--	2500	--	pF
C <sub>oss</sub>	Output Capacitance		--	170	--	
C <sub>rss</sub>	Reverse Transfer Capacitance		--	10	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t <sub>d(ON)</sub>	Turn-on Delay Time	I <sub>D</sub> =13.0A, V <sub>DD</sub> =325V V <sub>GS</sub> =10V, R <sub>g</sub> =9.1Ω	--	30	--	ns
t <sub>r</sub>	Rise Time		--	27	--	
t <sub>d(OFF)</sub>	Turn-Off Delay Time		--	68	--	
t <sub>f</sub>	Fall Time		--	48	--	
Q <sub>g</sub>	Total Gate Charge	I <sub>D</sub> =13.0A, V <sub>DD</sub> =325V V <sub>GS</sub> =10V	--	42	--	nC
Q <sub>gs</sub>	Gate to Source Charge		--	11	--	
Q <sub>gd</sub>	Gate to Drain ( "Miller" ) Charge		--	14.5	--	



# GL13N65FA9

无锡光磊电子科技有限公司

## GL Silicon N-Channel Power MOSFET

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)		--	--	13	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	52	A
$V_{SD}$	Diode Forward Voltage	$I_S = 13.0A, V_{GS} = 0V$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_S = 13.0A, T_J = 25^\circ C$	--	680	--	ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s, V_{GS} = 0V$	--	4500	--	nC
Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$						

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case	2.5	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient	100	$^\circ C/W$

<sup>a1</sup> : Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup> :  $L = 10.0mH, I_D = 14.6A, \text{Start } T_J = 25^\circ C$

<sup>a3</sup> :  $I_{SD} = 12A, di/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS}, \text{Start } T_J = 25^\circ C$



### Characteristics Curve :

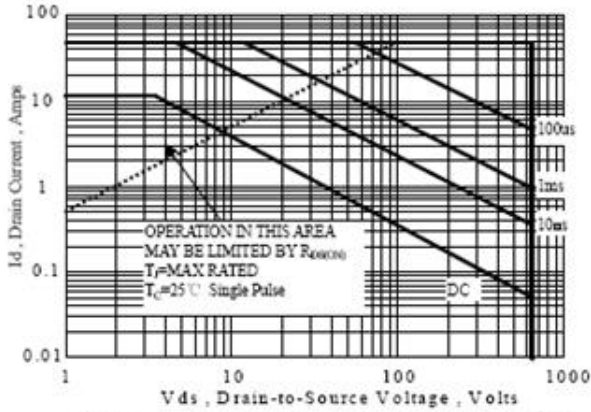


Figure 1 Maximum Forward Bias Safe Operating Area

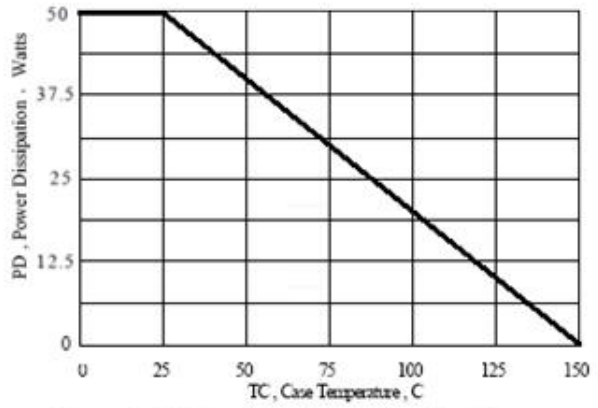


Figure 2 Maximum Power Dissipation vs Case Temperature

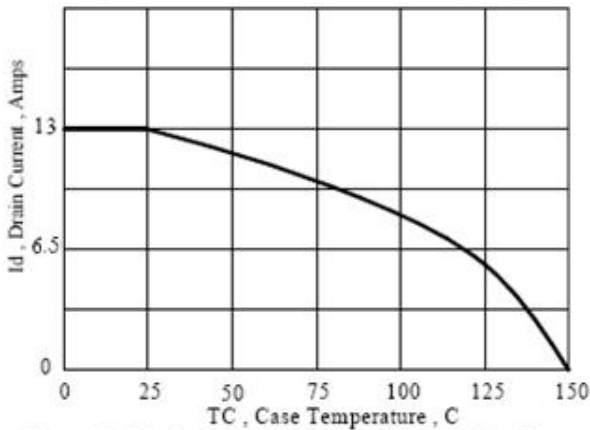


Figure 3 Maximum Continuous Drain Current vs Case Temperature

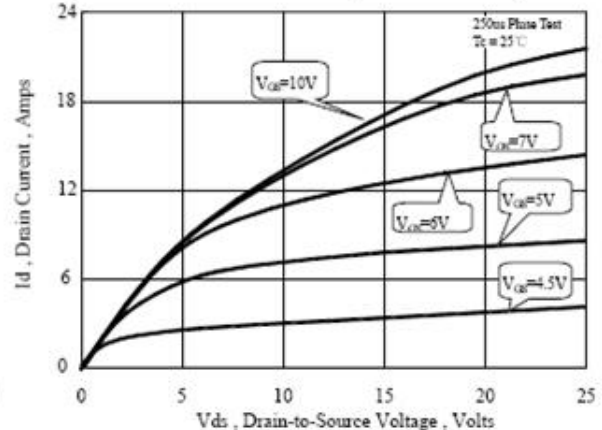


Figure 4 Typical Output Characteristics

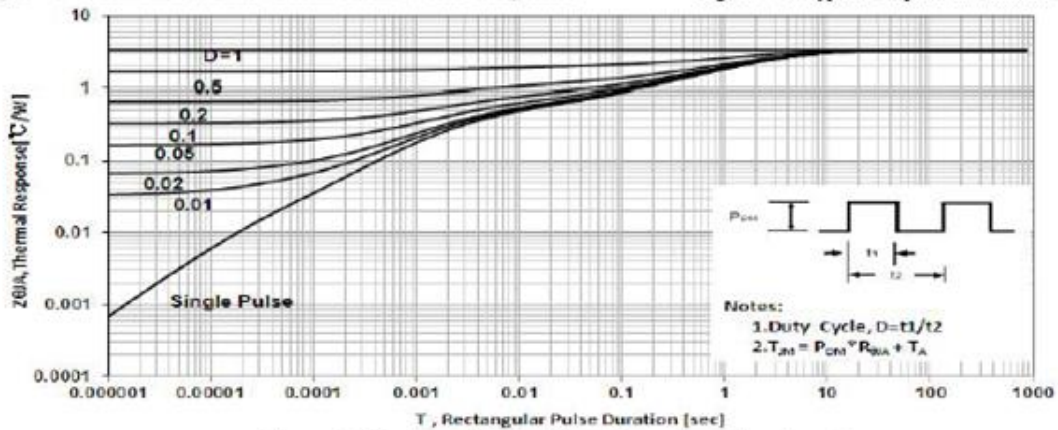


Figure 5 Maximum Effective Thermal Impedance, Junction to Case

## GL Silicon N-Channel Power MOSFET

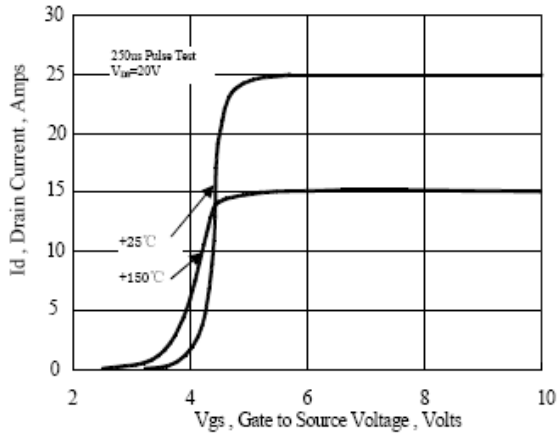


Figure 6 Typical Transfer Characteristics

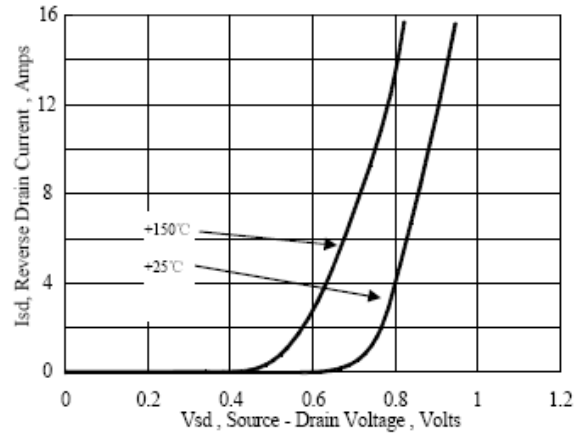


Figure 7 Typical Body Diode Transfer Characteristics

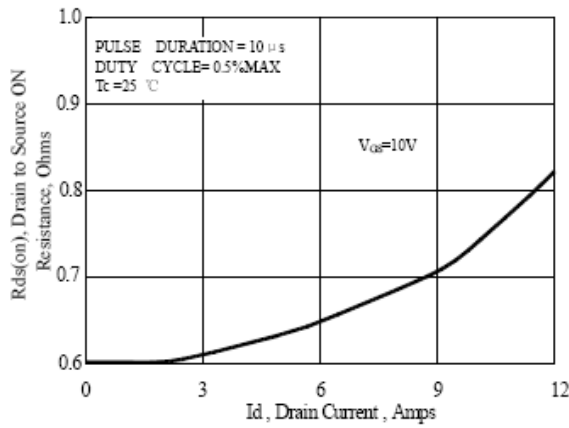


Figure 8 Typical Drain to Source ON Resistance vs Drain Current

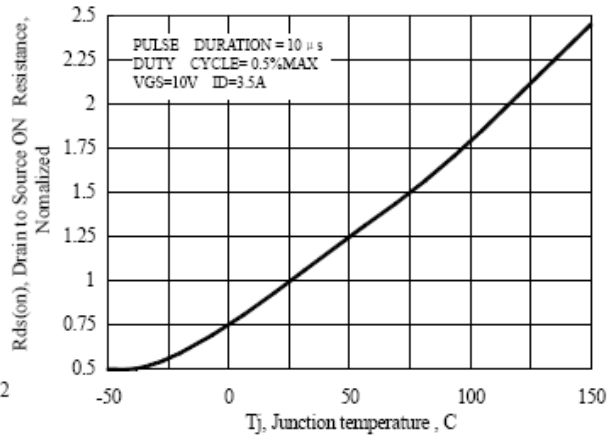


Figure 9 Typical Drain to Source on Resistance vs Junction Temperature

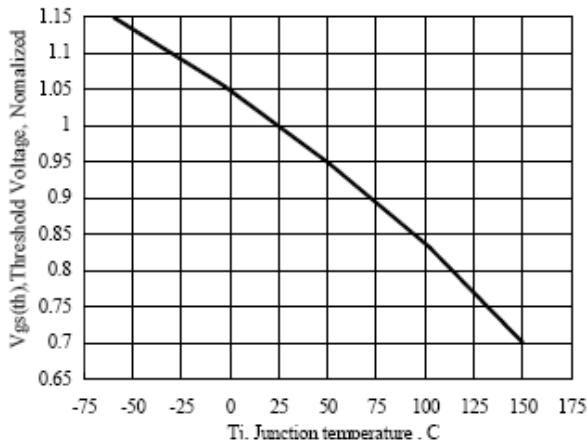


Figure 10 Typical Threshold Voltage vs Junction Temperature

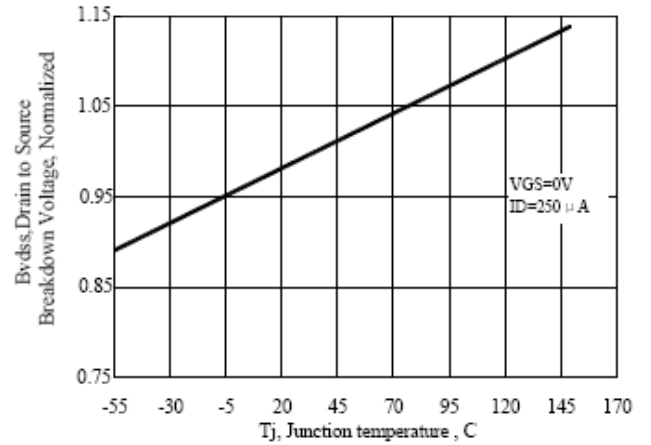


Figure 11 Typical Breakdown Voltage vs Junction Temperature



# GL13N65FA9

无锡光磊电子科技有限公司

## GL Silicon N-Channel Power MOSFET

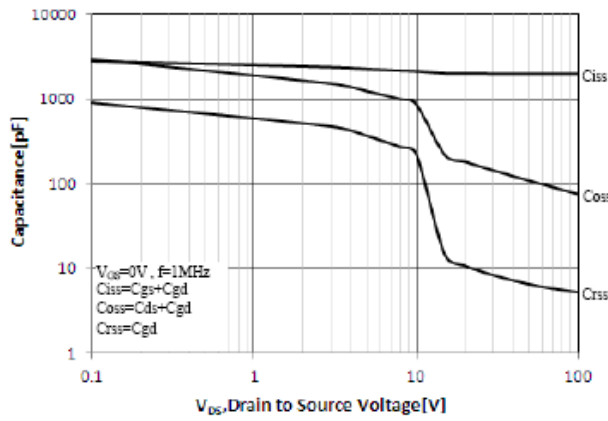


Figure 12 Typical Capacitance vs Drain to Source Voltage

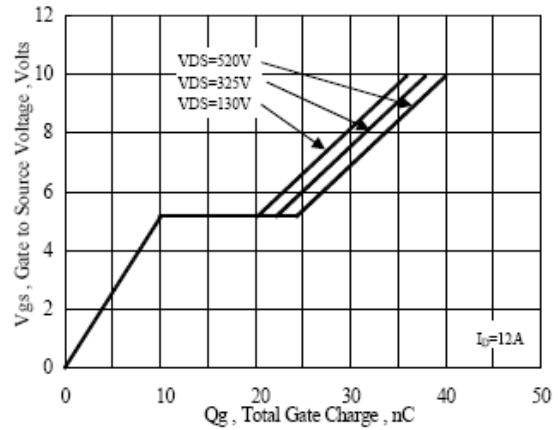


Figure 13 Typical Gate Charge vs Gate to Source Voltage

Company : Wuxi Guang Lei electronic technology co., LTD

TEL : 13961734102Mr.yuan

Wuxi Guang Lei electronic technology co., LTD